

### Quad Exclusive OR Gate

The TC74HC386A is a high speed CMOS EXCLUSIVE-OR GATE fabricated with silicon gate C<sup>2</sup>MOS technology.

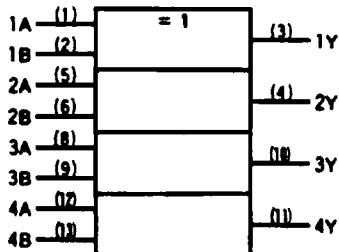
It achieves the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

The internal circuit is includes on output buffer, which provide high noise immunity and stable output.

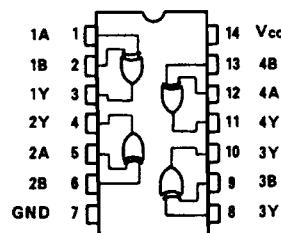
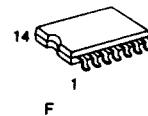
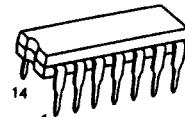
All inputs are equipped with protection circuits against static discharge or transient excess voltage.

### Features

- High Speed:  $t_{PD} = 10\text{ns}(\text{Typ.})$  at  $V_{CC} = 5\text{V}$
- Low Power Dissipation:  $I_{CC} = 1\mu\text{A}(\text{Max.})$  at  $T_a = 25^\circ\text{C}$
- High Noise Immunity:  $V_{NIH} = V_{NIL} = 28\% V_{CC}(\text{Min.})$
- Output Drive Capability: 10 LSTTL Loads
- Symmetrical Output Impedance:  $|I_{OHI}| = |I_{OL}| = 4\text{mA}(\text{Min.})$
- Balanced Propagation Delays:  $t_{PLH} = t_{PHL}$
- Wide Operating Voltage Range:  $V_{CC}(\text{opr}) = 2\text{V} \sim 6\text{V}$
- Pin and Function Compatible with 74LS386



IEC Logic Symbol



Pin Assignment

Truth Table

A	B	Y
L	L	L
L	H	H
H	L	H
H	H	L

**Absolute Maximum Ratings**

Parameter	Symbol	Value	Unit
Supply Voltage Range	V <sub>CC</sub>	-0.5 ~ 7	V
DC Input Voltage	V <sub>IN</sub>	-0.5 ~ V <sub>CC</sub> + 0.5	V
DC Output Voltage	V <sub>OUT</sub>	-0.5 ~ V <sub>CC</sub> + 0.5	V
Input Diode Current	I <sub>IK</sub>	±20	mA
Output Diode Current	I <sub>OK</sub>	±20	mA
DC Output Current	I <sub>OUT</sub>	±25	mA
DC V <sub>CC</sub> /Ground Current	I <sub>CC</sub>	±50	mA
Power Dissipation	P <sub>D</sub>	500(DIP)*/180(MFP)	mW
Storage Temperature	T <sub>STG</sub>	-65 ~ 150	°C
Lead Temperature 10sec	T <sub>L</sub>	300	°C

\*500mW in the range of Ta = -40°C ~ 65°C. From Ta = 65°C to 85°C a derating factor of -10mW/°C shall be applied until 300mW.

**Recommended Operating Conditions**

Parameter	Symbol	Value	Unit
Supply Voltage	V <sub>CC</sub>	2 ~ 6	V
Input Voltage	V <sub>IN</sub>	0 ~ V <sub>CC</sub>	V
Output Voltage	V <sub>OUT</sub>	0 ~ V <sub>CC</sub>	V
Operating Temperature	T <sub>OPR</sub>	-40 ~ 85	°C
Input Rise and Fall Time	t <sub>r</sub> , t <sub>f</sub>	0 ~ 1000(V <sub>CC</sub> = 2.0V) 0 ~ 500(V <sub>CC</sub> = 4.5V) 0 ~ 400(V <sub>CC</sub> = 6.0V)	ns

**DC Electrical Characteristics**

Parameter	Symbol	Test Condition		Ta = 25°C			Ta = -40 ~ 85°C		Unit		
				V <sub>CC</sub>	Min.	Typ.	Max.	Min.			
High-Level Input Voltage	V <sub>IH</sub>	-		2.0	1.5	—	—	1.5	—	V	
				4.5	3.15	—	—	3.15	—		
				6.0	4.2	—	—	4.2	—		
Low-Level Input Voltage	V <sub>IL</sub>	-		2.0	—	—	0.5	—	0.5	V	
				4.5	—	—	1.35	—	1.35		
				6.0	—	—	1.8	—	1.8		
High-Level Output Voltage	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -20µA	2.0	1.9	2.0	—	1.9	—	V	
				4.5	4.4	4.5	—	4.4	—		
		V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = -4 mA I <sub>OL</sub> = -5.2 mA	6.0	5.9	6.0	—	5.9	—		
				4.5	4.18	4.31	—	4.13	—		
Low-Level Output Voltage	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 20µA	6.0	5.68	5.80	—	5.63	—	V	
				2.0	—	0.0	0.1	—	0.1		
		V <sub>IN</sub> = V <sub>CC</sub> or GND	I <sub>OL</sub> = 4 mA I <sub>OL</sub> = 5.2 mA	4.5	—	0.0	0.1	—	0.1		
				6.0	—	0.0	0.1	—	0.1		
Input Leakage Current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		6.0	—	—	±0.1	—	±1.0	µA	
Quiescent Supply Current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		60	—	—	1.0	—	10.0		

AC Electrical Characteristics ( $C_L = 15\text{pF}$ ,  $V_{CC} = 5\text{V}$ ,  $T_a = 25^\circ\text{C}$ )

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Output Transition Time	$t_{TLH}$ $t_{THL}$	—	—	4	8	ns
Propagation Delay Time	$t_{pLH}$ $t_{pHL}$	—	—	10	17	

AC Electrical Characteristics ( $C_L = 50\text{pF}$ , Input  $t_r = t_f = 6\text{ns}$ )

Parameter	Symbol	Test Condition	$V_{CC}$	$T_a = 25^\circ\text{C}$			$T_a = -40 \sim 85^\circ\text{C}$		Unit
			Min.	Typ.	Max.	Min.	Max.	Min.	
Output Transition Time	$t_{TLH}$ $t_{THL}$	—	2.0	—	30	75	—	95	ns
			4.5	—	8	15	—	19	
			6.0	—	7	13	—	16	
Propagation Delay Time	$t_{pLH}$ $t_{pHL}$	—	2.0	—	48	100	—	125	ns
			4.5	—	12	20	—	25	
			6.0	—	11	17	—	21	
Input Capacitance	$C_{IN}$	—	—	5	10	—	—	10	pF
Power Dissipation Capacitance	$C_{PD(1)}$	—	—	55	—	—	—	—	

Note (1)  $C_{PD}$  is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$I_{CC(\text{avg})} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/4 \text{(per Gate)}$$

**Notes**